



INFORMATION DISCLOSURE STATEMENT LIST (Use as many sheets as necessary)	Complete if Known	
	Application Number	10/586,597
	Filing Date	7/19/2006
	First Named Inventor	FRANKLIN
	Group Art Unit	1615
	Examiner Name	LEVY, NEIL S

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NON-PATENT DOCUMENTS		
Examiner's Initials	Cite No.	Non-Patent Citations (include Author, Title, Publisher, Relevant Pages, Date and Place of Publication)
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	B32	Database WPI/Derwent, AN 198156193D [31], XP-002297962 (Abstract)
	B33	Database WPI/Derwent, AN 1985-047717 [08] and JP 19830113680 19830624 XP-002297961 (Abstract)

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